## IAP20 Rec's 75 77 30 MAR 2006

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FORM PTO-1449  U.S. DEPARTMENT OF COMME PATENT AND TRADEMARK OFF						1454.1698				TION NO.
INFORMATION DISCLOSURE STATEMENT						FIRST NAMED INVENTOR				
THE OTHER PROPERTY.						Achim LUFT				
			h.,		GROOF A	AIT OIII				
						Concurrent	<u>y</u>			
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	l	DOCUMENT	FOREIGN I	PATENT DOC	UM	ENTS	<u> </u>			
		NO.	DATE	C	OUN	ITRY	TRANS YES			ABSTRACT
/P.N./	AG	1 289 241 A1	03/05/2003	BEUROPE						
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OTHER RE	FERE	NCES (Including	Author, litle	e, Date, Pertii	nen	t Pages, Etc	;.)			YES NO
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citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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ATTACHMENT 1(g)

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_	ATTORNEY DOCKET NO.		APPLICATION NO.
	1454.1698	1 0	E7307A
	FIRST NAMED INVENTOR		77777
	Achim LUFT		
	FILING DATE		GROUP ART UNIT
	Concurrently		

The following document(s) is/are listed in accordance with the duty of disclosure provisions of 37 CFR § 1.56, so that the Examiner may consider same should he deem any thereof to be material to examination of the subject application.

It is requested that the Examiner acknowledge his consideration of document(s) below-listed by initialling same in the space provided adjacent each such application and that the Examiner sign and date this form at the bottom thereof to confirm such consideration having been given.

This submission in no way represents an admission that any of the information listed herein constitutes prior art with respect to the subject application; and unless and until such prior art status is established, this submission is not a request that the information presented herein be printed on the face of any patent issuing from the subject application in which this information is being filed.

## **U.S. PATENT DOCUMENTS**

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*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
	AB						

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSL YES	ATION NO
AC							
AD							

OTHER DO	TRANSL YES	ATION NO		
/P.N./	AE	International Search Report for Application No. PCT/EP2004/051879 mailed March 15, 2005	х	

EXAMINER /Phung Hoang Nguyen/	DATE CONSIDERED 06/02/2008
*EXAMINER: Initial if document considered, whether or not cit citation if not in conformance and not considered. Include copy of	